


<b>Search Notes</b>  	<b>Application/Control No.</b>  10630099	<b>Applicant(s)/Patent Under Reexamination</b>  MARTINEZ PEREZ ET AL.
	<b>Examiner</b>  Wai, Eric C	<b>Art Unit</b>  2195

SEARCHED			
Class	Subclass	Date	Examiner
718	104	05/21/2007	ECW
713	1,2,100	1/16/2008	ECW

SEARCH NOTES		
Search Notes	Date	Examiner
East Search	05/21/2007	ECW
Inventor's Name Search	05/21/2007	ECW
Updated East Search	9/21/2007	ECW
Updated East Search	1/16/2008	ECW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner